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**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

*In re* Application of Honkanen  
Serial No.: 10/681,491  
Filed: October 7, 2003  
Customer No.: 29683  
Title: METHOD AND APPARATUS FOR DATA STRUCTURE ANALYZING

Atty. Docket:  
855.0007.U1(US)  
Art Unit: 2129  
Examiner: Fernandez Rivas,  
Omar  
Confirmation No.: 5898

**INTERVIEW SUMMARY**

Mail Stop AF  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

This paper memorializes a telephonic interview with Examiner Fernandez Rivas on June 6, 2006 in the above-captioned case in which the below-signed Applicant's Representative participated. In the telephonic interview, Applicant's representative and the Examiner agreed that there was a factual difference between the subject matter relied upon by the Examiner in rejecting the claims and Applicant's invention as described in the specification. Applicant respectfully submitted that the difference was already reflected in the independent claims, and the Examiner disagreed. In particular, the Khoshgoftaar references described using neural networks to assess fault tolerance of blocks of program code, whereas in Applicants' invention neural networks are used to assess risk associated with data structures. Applicant's representative argued that this distinction was already reflected in the claims, and the Examiner disagreed. No agreement was reached.



Respectfully submitted,

July 30, 2007  
Date

David M. O'Neill (35,304)

David M. O'Neill (35,304)  
Customer No.: 29683  
HARRINGTON & SMITH, LLP  
4 Research Drive  
Shelton, CT 06484-6212  
Telephone: (203) 925-9400

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**CERTIFICATE OF MAILING**

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents, P.O. 1450, Alexandria, VA 22313-1450 on the date indicated.

July 30, 2007  
Date

Julia Smith  
Name of Person Making Deposit